

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,443	YUE ET AL.
Examiner	Art Unit
Leslie Pascal	2633

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
see search notes		10/18/2005	LP	
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